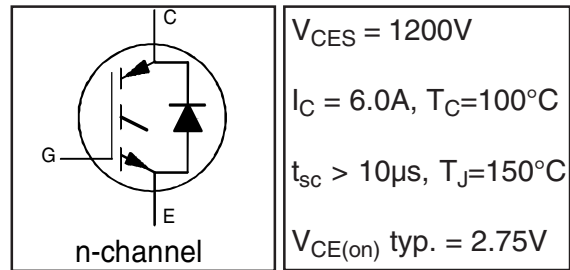


# IRGB5B120KD

## INSULATED GATE BIPOLAR TRANSISTOR WITH ULTRAFAST SOFT RECOVERY DIODE

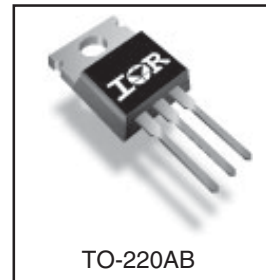
### Features

- Low VCE (on) Non Punch Through IGBT Technology.
- Low Diode VF.
- 10µs Short Circuit Capability.
- Square RBSOA.
- Ultrasoft Diode Reverse Recovery Characteristics.
- Positive VCE (on) Temperature Coefficient.
- TO-220 Package.



### Benefits

- Benchmark Efficiency for Motor Control.
- Rugged Transient Performance.
- Low EMI.
- Excellent Current Sharing in Parallel Operation.



### Absolute Maximum Ratings

	Parameter	Max.	Units
$V_{CES}$	Collector-to-Emitter Voltage	1200	V
$I_C @ T_C = 25^\circ\text{C}$	Continuous Collector Current	12	A
$I_C @ T_C = 100^\circ\text{C}$	Continuous Collector Current	6.0	
$I_{CM}$	Pulsed Collector Current	24	
$I_{LM}$	Clamped Inductive Load Current $\text{\textcircled{D}}$	24	
$I_F @ T_C = 25^\circ\text{C}$	Diode Continuous Forward Current	12	
$I_F @ T_C = 100^\circ\text{C}$	Diode Continuous Forward Current	6.0	
$I_{FM}$	Diode Maximum Forward Current	24	
$V_{GE}$	Gate-to-Emitter Voltage	$\pm 20$	V
$P_D @ T_C = 25^\circ\text{C}$	Maximum Power Dissipation	89	W
$P_D @ T_C = 100^\circ\text{C}$	Maximum Power Dissipation	36	
$T_J$	Operating Junction and	-55 to +150	$^\circ\text{C}$
$T_{STG}$	Storage Temperature Range		
	Soldering Temperature, for 10 sec.	300 (0.063 in. (1.6mm) from case)	
	Mounting Torque, 6-32 or M3 Screw.	10 lbf•in (1.1 N•m)	

### Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case - IGBT	—	—	1.4	$^\circ\text{C}/\text{W}$
$R_{\theta JC}$	Junction-to-Case - Diode	—	—	2.8	
$R_{\theta CS}$	Case-to-Sink, flat, greased surface	—	0.50	—	
$R_{\theta JA}$	Junction-to-Ambient, typical socket mount	—	—	62	
$Wt$	Weight	—	2 (0.07)	—	g (oz)

# IRGB5B120KD

International  
IR Rectifier

## Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions	Ref.Fig.
V <sub>(BR)CES</sub>	Collector-to-Emitter Breakdown Voltage	1200	—	—	V	V <sub>GE</sub> = 0V, I <sub>C</sub> = 500μA	
ΔV <sub>(BR)CES/ΔT<sub>J</sub></sub>	Temperature Coeff. of Breakdown Voltage	—	1.15	—	V/°C	V <sub>GE</sub> = 0V, I <sub>C</sub> = 1.0mA, (25°C-125°C)	
V <sub>CE(on)</sub>	Collector-to-Emitter Saturation Voltage	—	2.75	3.0	V	I <sub>C</sub> = 6.0A V <sub>GE</sub> = 15V	5, 6, 7
		—	3.36	3.7		I <sub>C</sub> = 6.0A V <sub>GE</sub> = 15V T <sub>J</sub> = 125°C	9, 10, 11
V <sub>GE(th)</sub>	Gate Threshold Voltage	4.0	5.0	6.0	V	V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 250μA	9, 10, 11
ΔV <sub>GE(th)/ΔT<sub>J</sub></sub>	Temperature Coeff. of Threshold Voltage	—	-11	—	mV/°C	V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 1.0mA, (25°C-125°C)	12
g <sub>fe</sub>	Forward Transconductance	—	2.6	—	S	V <sub>CE</sub> = 50V, I <sub>C</sub> = 6.0A, PW=80μs	
I <sub>CES</sub>	Zero Gate Voltage Collector Current	—	—	100	μA	V <sub>GE</sub> = 0V, V <sub>CE</sub> = 1200V	
		—	66	200		V <sub>GE</sub> = 0V, V <sub>CE</sub> = 1200V, T <sub>J</sub> = 125°C	
V <sub>FM</sub>	Diode Forward Voltage Drop	—	2.13	2.45	V	I <sub>F</sub> = 6.0A	8
		—	2.38	2.75		I <sub>F</sub> = 6.0A T <sub>J</sub> = 125°C	
I <sub>GES</sub>	Gate-to-Emitter Leakage Current	—	—	±100	nA	V <sub>GE</sub> = ±20V	

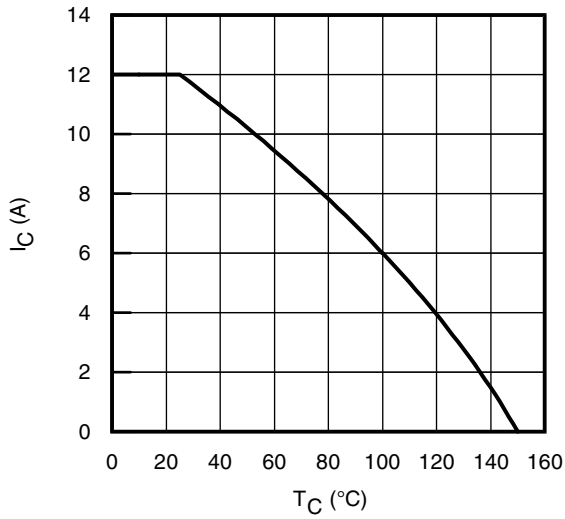
## Switching Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions	Ref.Fig.
Q <sub>g</sub>	Total Gate Charge (turn-on)	—	25	38	nC	I <sub>C</sub> = 6.0A	23
Q <sub>ge</sub>	Gate - Emitter Charge (turn-on)	—	3.7	5.6		V <sub>CC</sub> = 800V	CT1
Q <sub>gc</sub>	Gate - Collector Charge (turn-on)	—	13	20		V <sub>GE</sub> = 15V	
E <sub>on</sub>	Turn-On Switching Loss	—	390	440	μJ	I <sub>C</sub> = 6.0A, V <sub>CC</sub> = 600V	CT4
E <sub>off</sub>	Turn-Off Switching Loss	—	330	440		V <sub>GE</sub> = 15V, R <sub>G</sub> = 50Ω, L = 3.7mH	
E <sub>tot</sub>	Total Switching Loss	—	720	880		L <sub>s</sub> = 150nH T <sub>J</sub> = 25°C ⊙	
t <sub>d(on)</sub>	Turn-On Delay Time	—	22	29	ns	I <sub>C</sub> = 6.0A, V <sub>CC</sub> = 600V	CT4
t <sub>r</sub>	Rise Time	—	19	27		V <sub>GE</sub> = 15V, R <sub>G</sub> = 50Ω L = 3.7mH	
t <sub>d(off)</sub>	Turn-Off Delay Time	—	100	120		L <sub>s</sub> = 150nH, T <sub>J</sub> = 25°C	
t <sub>f</sub>	Fall Time	—	19	25			
E <sub>on</sub>	Turn-On Switching Loss	—	440	660	μJ	I <sub>C</sub> = 6.0A, V <sub>CC</sub> = 600V	CT4
E <sub>off</sub>	Turn-Off Switching Loss	—	370	560		V <sub>GE</sub> = 15V, R <sub>G</sub> = 50Ω, L = 3.7mH	
E <sub>tot</sub>	Total Switching Loss	—	810	1220		L <sub>s</sub> = 150nH T <sub>J</sub> = 125°C ⊙	
t <sub>d(on)</sub>	Turn-On Delay Time	—	21	27	ns	I <sub>C</sub> = 6.0A, V <sub>CC</sub> = 600V	14, 16
t <sub>r</sub>	Rise Time	—	18	25		V <sub>GE</sub> = 15V, R <sub>G</sub> = 50Ω L = 3.7mH	
t <sub>d(off)</sub>	Turn-Off Delay Time	—	110	150		L <sub>s</sub> = 150nH, T <sub>J</sub> = 125°C	
t <sub>f</sub>	Fall Time	—	22	29			
C <sub>ies</sub>	Input Capacitance	—	370	—	pF	V <sub>GE</sub> = 0V	22
C <sub>oes</sub>	Output Capacitance	—	33	—		V <sub>CC</sub> = 30V	
C <sub>res</sub>	Reverse Transfer Capacitance	—	11	—		f = 1.0MHz	
RBSOA	Reverse Bias Safe Operating Area	FULL SQUARE				T <sub>J</sub> = 150°C, I <sub>C</sub> = 24A, V <sub>p</sub> = 1200V V <sub>CC</sub> = 1000V, V <sub>GE</sub> = +15V to 0V, R <sub>G</sub> = 50Ω	4 CT2
SCSOA	Short Circuit Safe Operating Area	10	—	—	μs	T <sub>J</sub> = 150°C, V <sub>p</sub> = 1200V, R <sub>G</sub> = 50Ω V <sub>CC</sub> = 900V, V <sub>GE</sub> = +15V to 0V	CT3 WF4
E <sub>rec</sub>	Reverse Recovery energy of the diode	—	360	—	μJ	T <sub>J</sub> = 125°C	17, 18, 19
t <sub>rr</sub>	Diode Reverse Recovery time	—	160	—	ns	V <sub>CC</sub> = 600V, I <sub>F</sub> = 6.0A, L = 2.0mH	20, 21
I <sub>rr</sub>	Diode Peak Reverse Recovery Current	—	9.0	—	A	V <sub>GE</sub> = 15V, R <sub>G</sub> = 50Ω, L <sub>s</sub> = 150nH	CT4, WF3

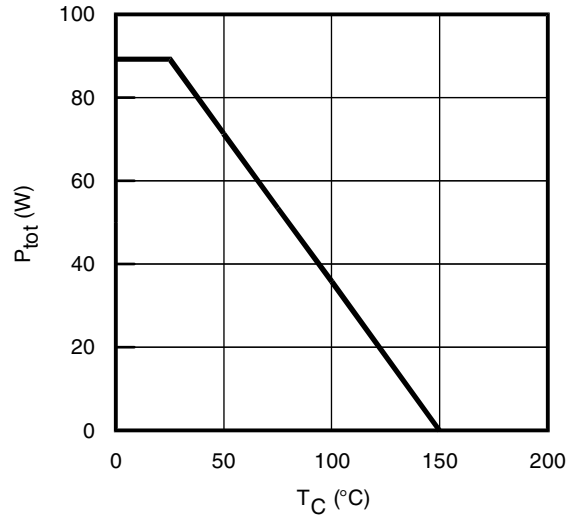
### Note:

⊙ V<sub>CC</sub> = 80% (V<sub>CES</sub>), V<sub>GE</sub> = 15V, L = 100μH, R<sub>G</sub> = 50Ω.

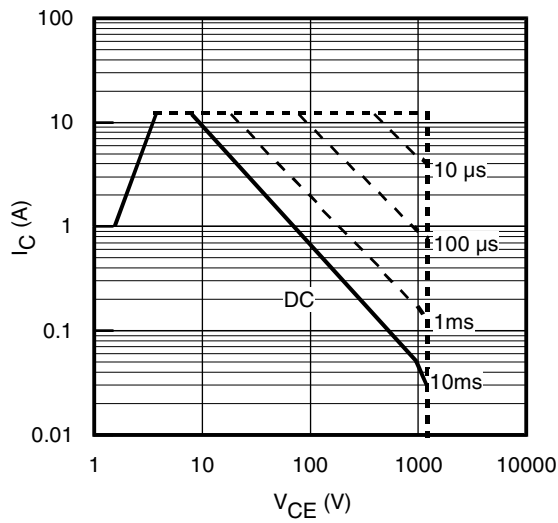
⊙ Energy losses include "tail" and diode reverse recovery.



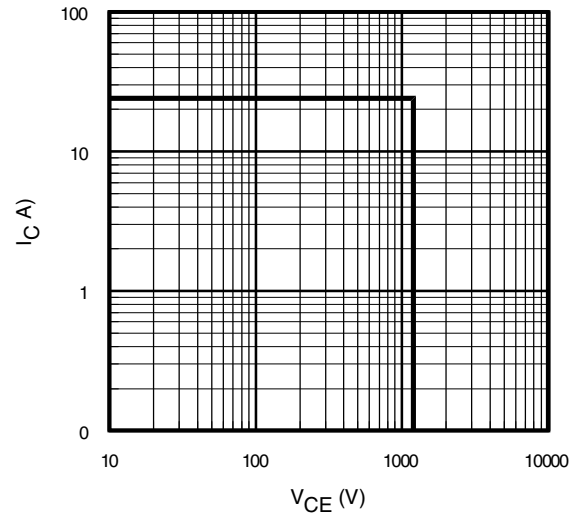
**Fig. 1** - Maximum DC Collector Current vs. Case Temperature



**Fig. 2** - Power Dissipation vs. Case Temperature

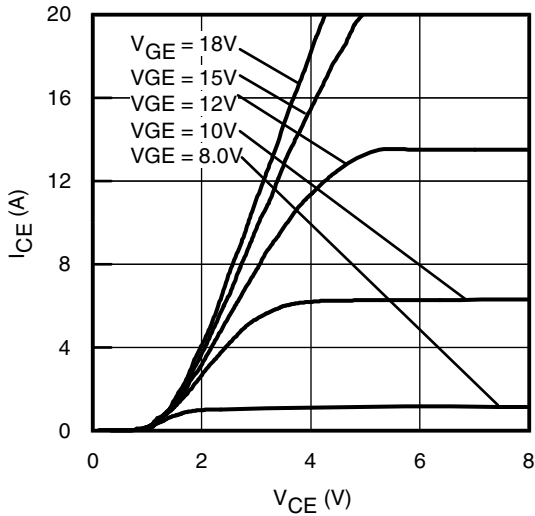


**Fig. 3** - Forward SOA  
 $T_C = 25^\circ\text{C}$ ;  $T_J \leq 150^\circ\text{C}$

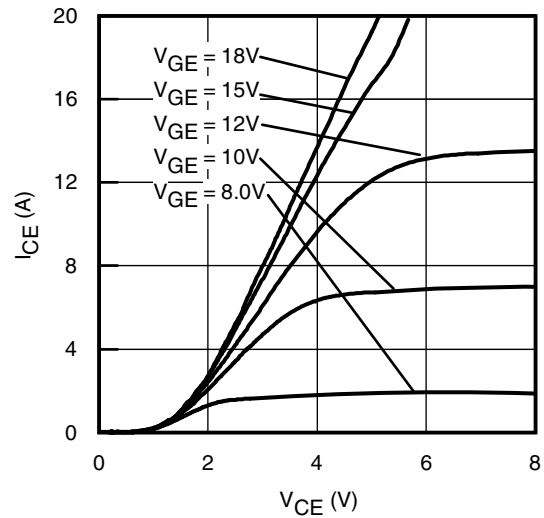


**Fig. 4** - Reverse Bias SOA  
 $T_J = 150^\circ\text{C}$ ;  $V_{GE} = 15\text{V}$

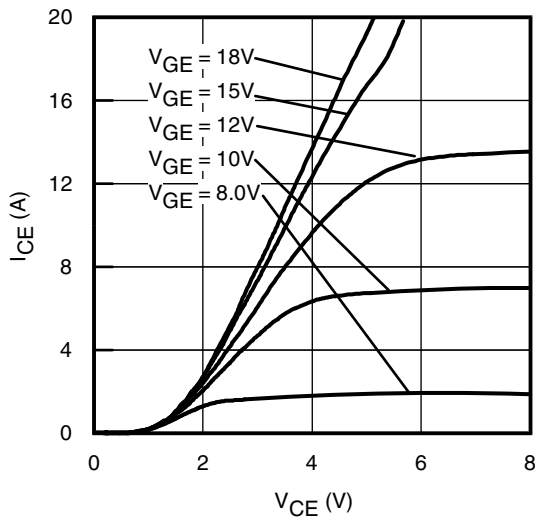
# IRGB5B120KD



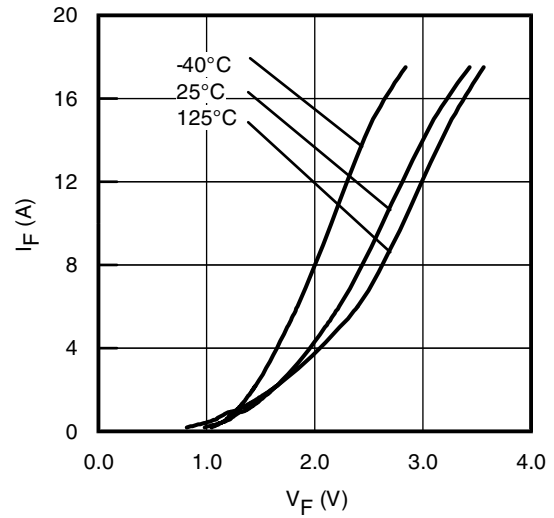
**Fig. 5** - Typ. IGBT Output Characteristics  
 $T_J = -40^\circ\text{C}$ ;  $t_p = 80\mu\text{s}$



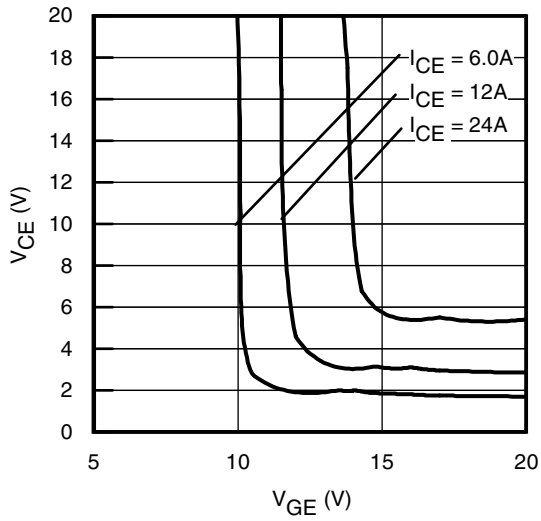
**Fig. 6** - Typ. IGBT Output Characteristics  
 $T_J = 25^\circ\text{C}$ ;  $t_p = 80\mu\text{s}$



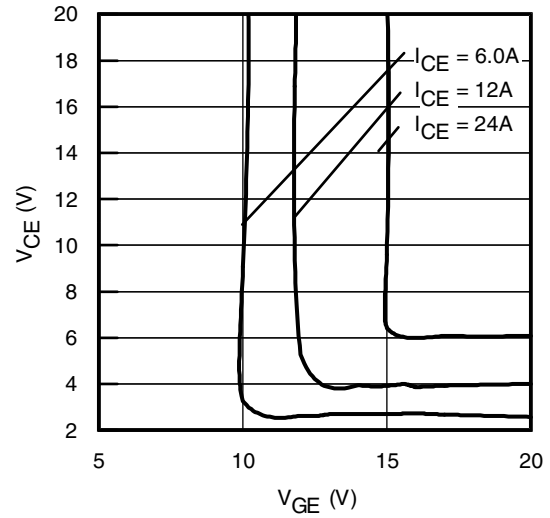
**Fig. 7** - Typ. IGBT Output Characteristics  
 $T_J = 125^\circ\text{C}$ ;  $t_p = 80\mu\text{s}$



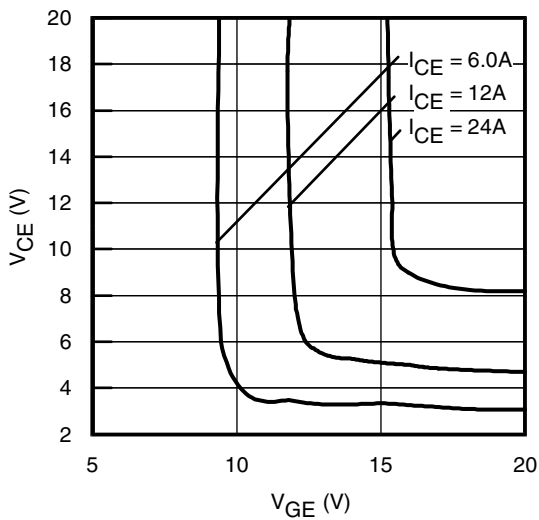
**Fig. 8** - Typ. Diode Forward Characteristics  
 $t_p = 80\mu\text{s}$



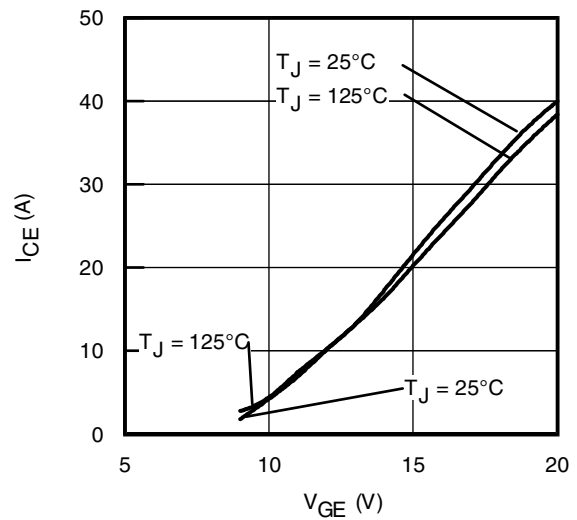
**Fig. 9** - Typical  $V_{CE}$  vs.  $V_{GE}$   
 $T_J = -40^\circ\text{C}$



**Fig. 10** - Typical  $V_{CE}$  vs.  $V_{GE}$   
 $T_J = 25^\circ\text{C}$

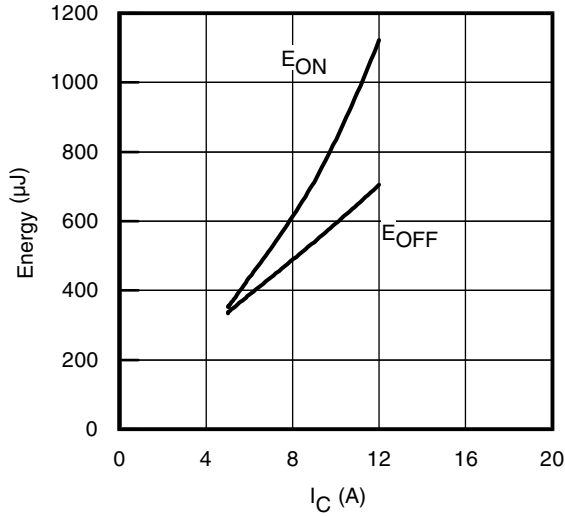


**Fig. 11** - Typical  $V_{CE}$  vs.  $V_{GE}$   
 $T_J = 125^\circ\text{C}$

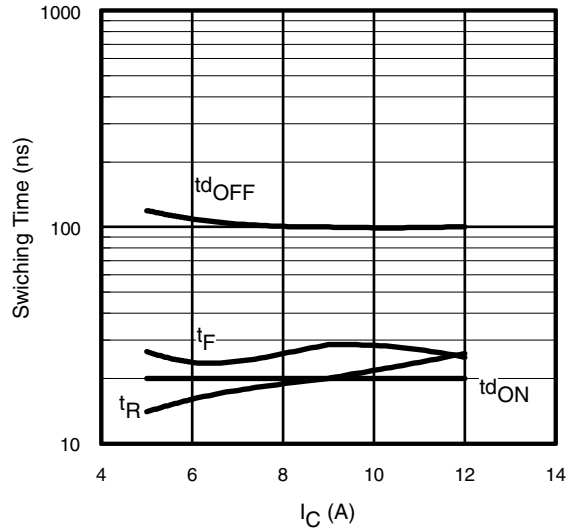


**Fig. 12** - Typ. Transfer Characteristics  
 $V_{CE} = 50\text{V}$ ;  $t_p = 10\mu\text{s}$

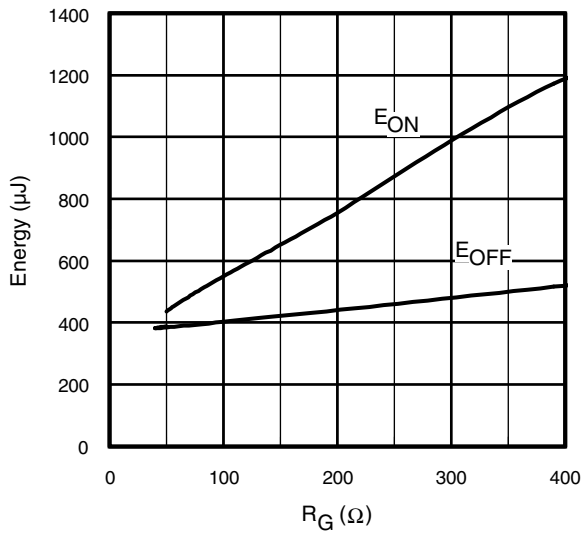
# IRGB5B120KD



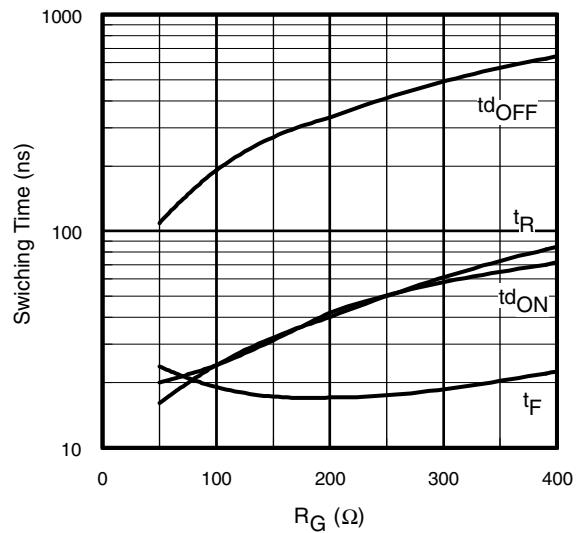
**Fig. 13** - Typ. Energy Loss vs.  $I_C$   
 $T_J = 125^\circ\text{C}$ ;  $L=3.7\text{mH}$ ;  $V_{CE}= 600\text{V}$   
 $R_G= 50\Omega$ ;  $V_{GE}= 15\text{V}$



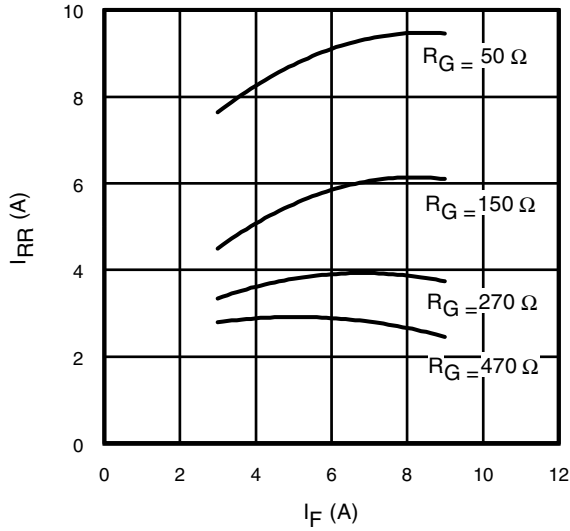
**Fig. 14** - Typ. Switching Time vs.  $I_C$   
 $T_J = 125^\circ\text{C}$ ;  $L=3.7\text{mH}$ ;  $V_{CE}= 600\text{V}$   
 $R_G= 50\Omega$ ;  $V_{GE}= 15\text{V}$



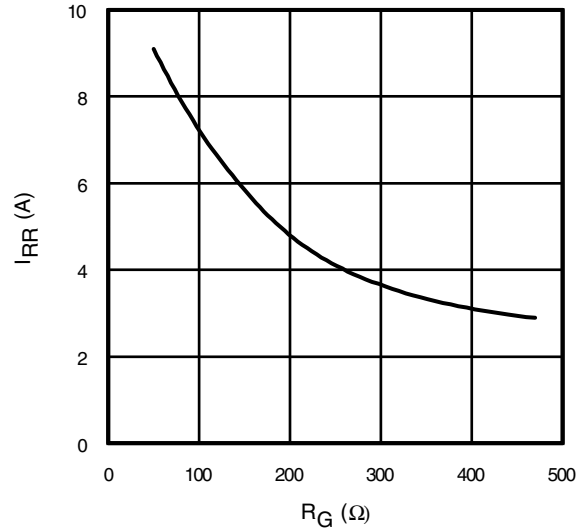
**Fig. 15** - Typ. Energy Loss vs.  $R_G$   
 $T_J = 125^\circ\text{C}$ ;  $L=3.7\text{mH}$ ;  $V_{CE}= 600\text{V}$   
 $I_{CE}= 6.0\text{A}$ ;  $V_{GE}= 15\text{V}$



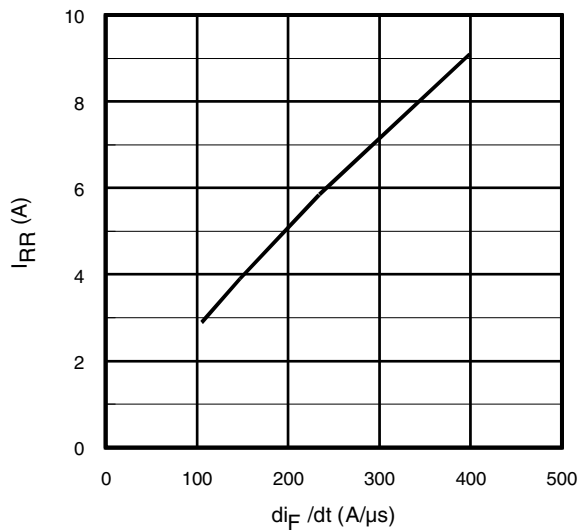
**Fig. 16** - Typ. Switching Time vs.  $R_G$   
 $T_J = 125^\circ\text{C}$ ;  $L=3.7\text{mH}$ ;  $V_{CE}= 600\text{V}$   
 $I_{CE}= 6.0\text{A}$ ;  $V_{GE}= 15\text{V}$



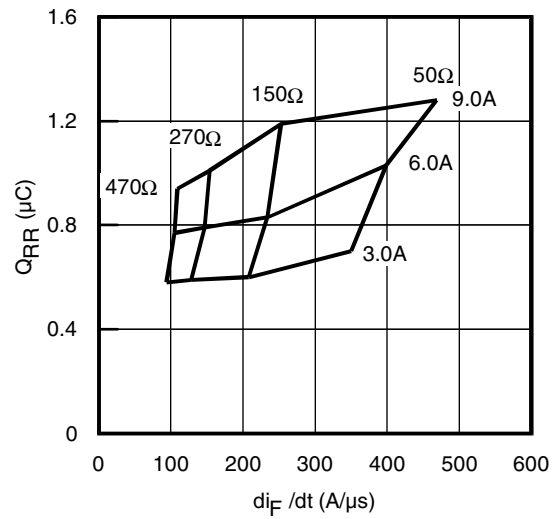
**Fig. 17** - Typical Diode  $I_{RR}$  vs.  $I_F$   
 $T_J = 125^\circ\text{C}$



**Fig. 18** - Typical Diode  $I_{RR}$  vs.  $R_G$   
 $T_J = 125^\circ\text{C}$ ;  $I_F = 6.0\text{A}$

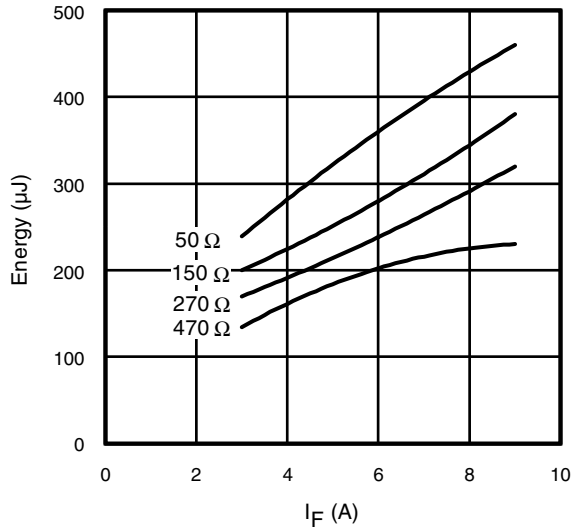


**Fig. 19**- Typical Diode  $I_{RR}$  vs.  $di_F/dt$   
 $V_{CC} = 600\text{V}$ ;  $V_{GE} = 15\text{V}$ ;  
 $I_F = 6.0\text{A}$ ;  $T_J = 125^\circ\text{C}$

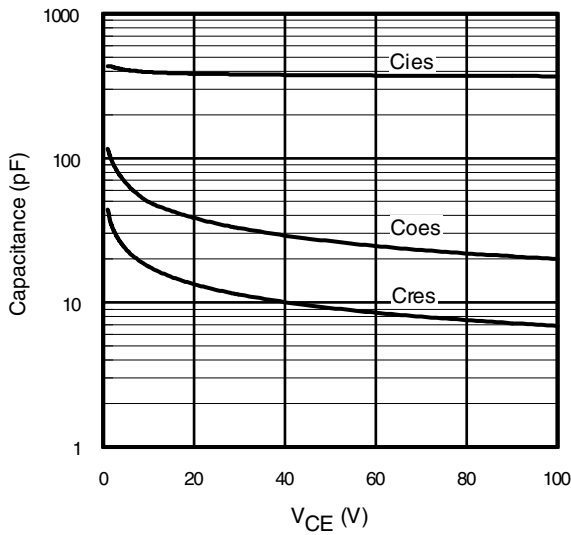


**Fig. 20** - Typical Diode  $Q_{RR}$   
 $V_{CC} = 600\text{V}$ ;  $V_{GE} = 15\text{V}$ ;  $T_J = 125^\circ\text{C}$

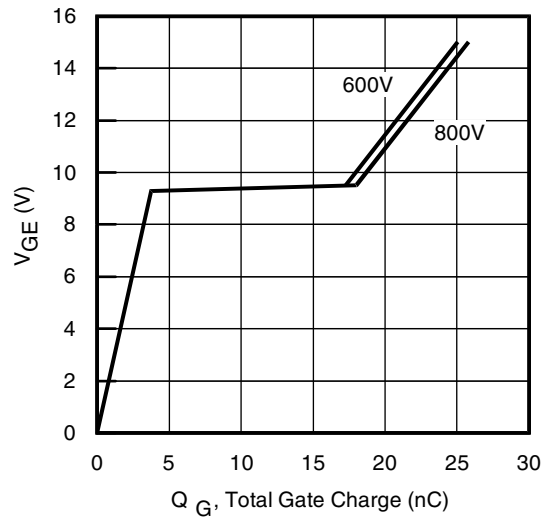
# IRGB5B120KD



**Fig. 21** - Typical Diode  $E_{RR}$  vs.  $I_F$   
 $T_J = 125^\circ\text{C}$

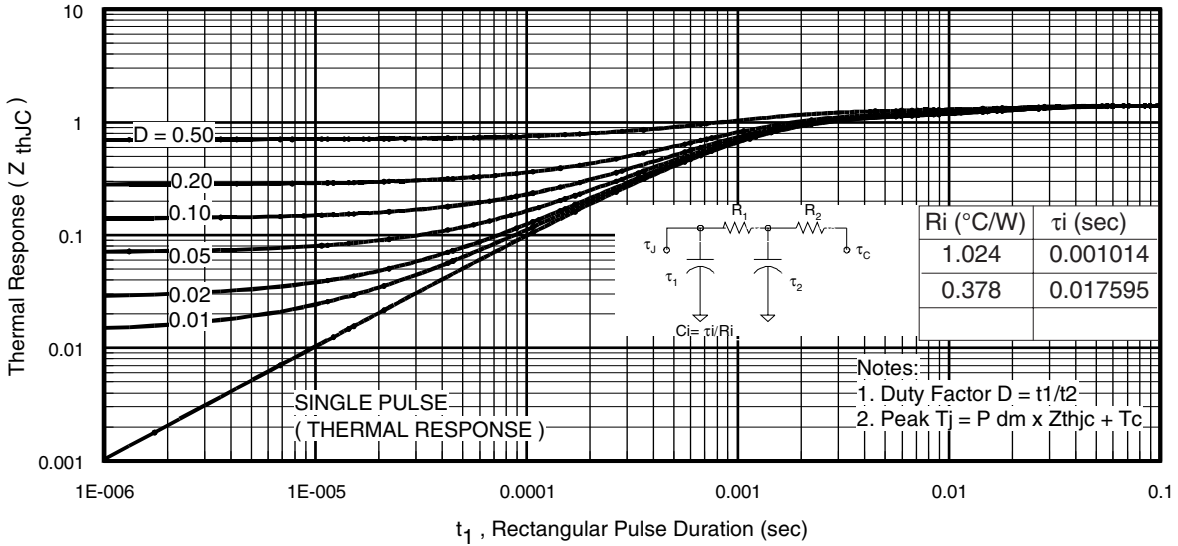


**Fig. 22**- Typ. Capacitance vs.  $V_{CE}$   
 $V_{GE} = 0\text{V}$ ;  $f = 1\text{MHz}$

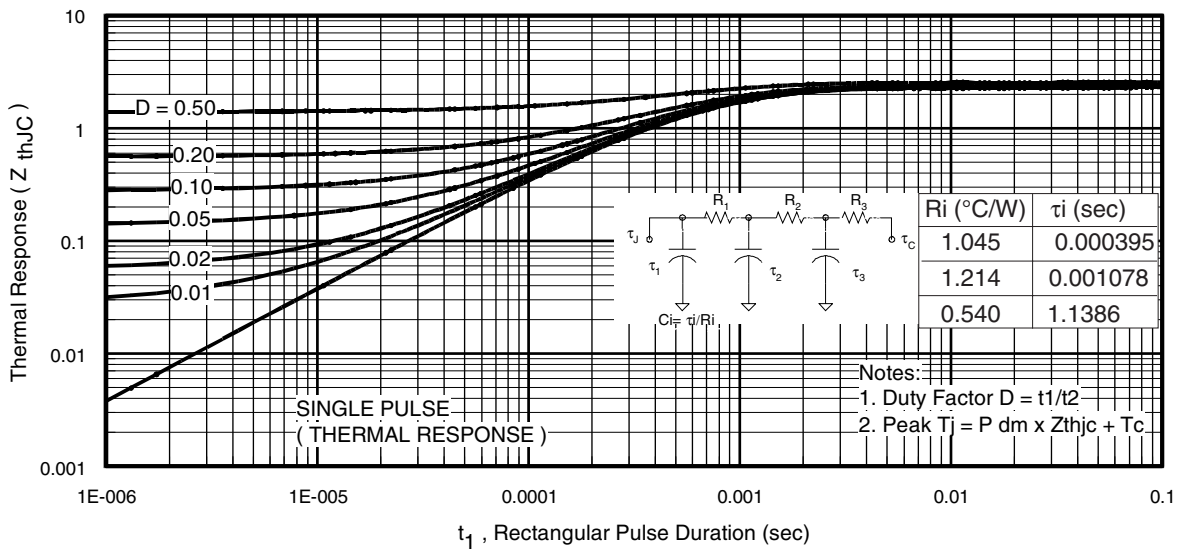


**Fig. 23** - Typical Gate Charge vs.  $V_{GE}$   
 $I_{CE} = 6.0\text{A}$ ;  $L = 600\mu\text{H}$



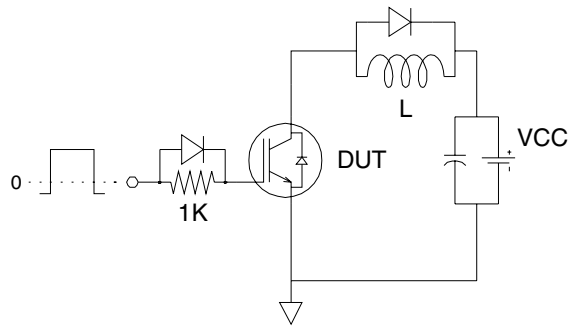


**Fig 24.** Maximum Transient Thermal Impedance, Junction-to-Case (IGBT)

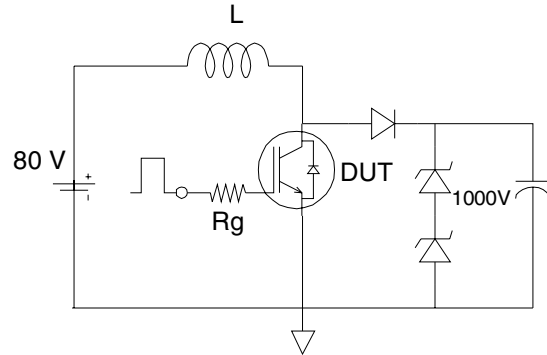


**Fig 25.** Maximum Transient Thermal Impedance, Junction-to-Case (DIODE)

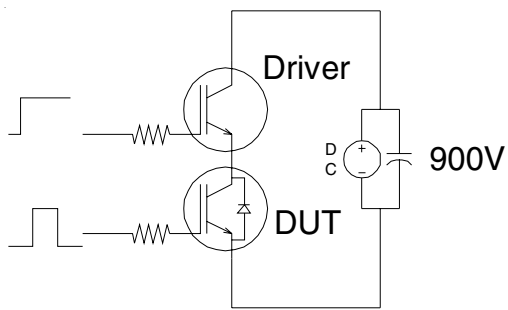
# IRGB5B120KD



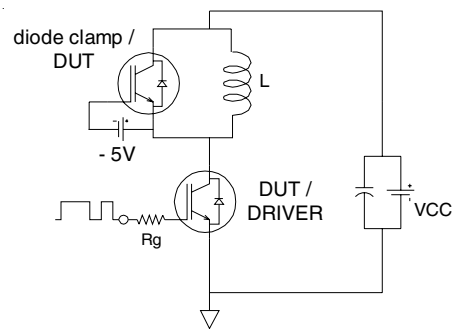
**Fig.C.T.1** - Gate Charge Circuit (turn-off)



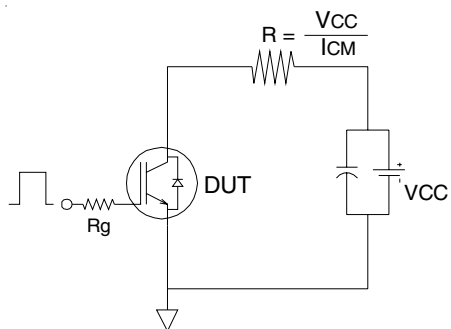
**Fig.C.T.2** - RBSOA Circuit



**Fig.C.T.3** - S.C. SOA Circuit



**Fig.C.T.4** - Switching Loss Circuit



**Fig.C.T.5** - Resistive Load Circuit

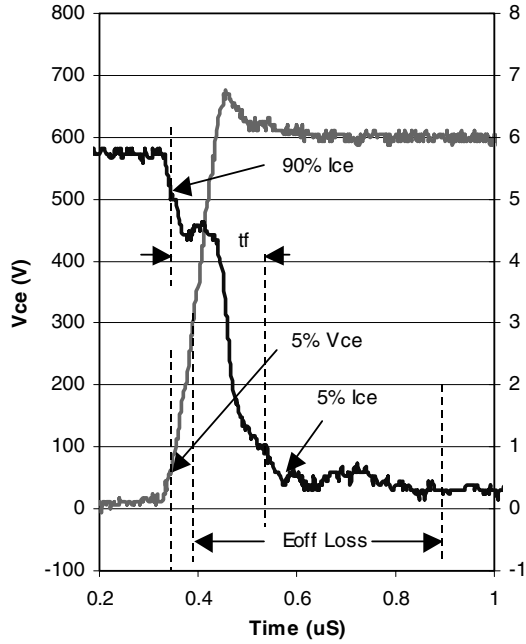


Fig.WF2-Typ. Turn-off Loss Waveform  
@  $T_J = 125^\circ\text{C}$  using Fig. CT4

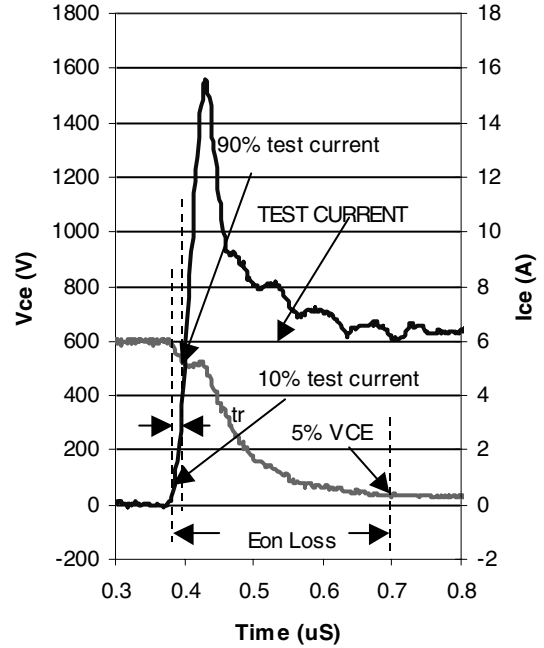


Fig.WF2-Typ. Turn-on Loss Waveform  
@  $T_J = 125^\circ\text{C}$  using Fig. CT4

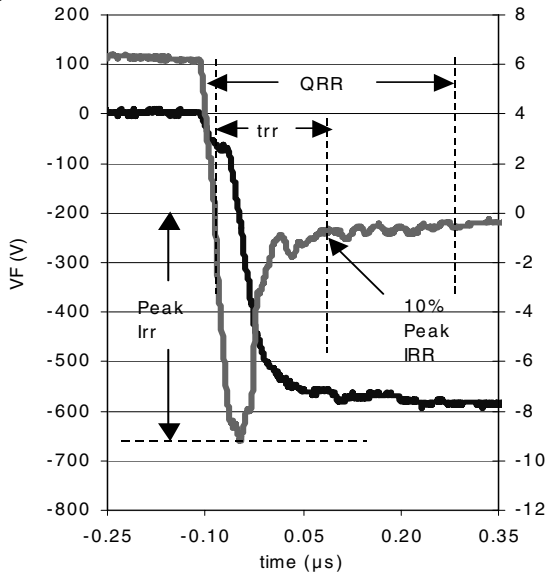


Fig.WF3-Typ. Diode Recovery Waveform  
@  $T_J = 125^\circ\text{C}$  using Fig. CT4

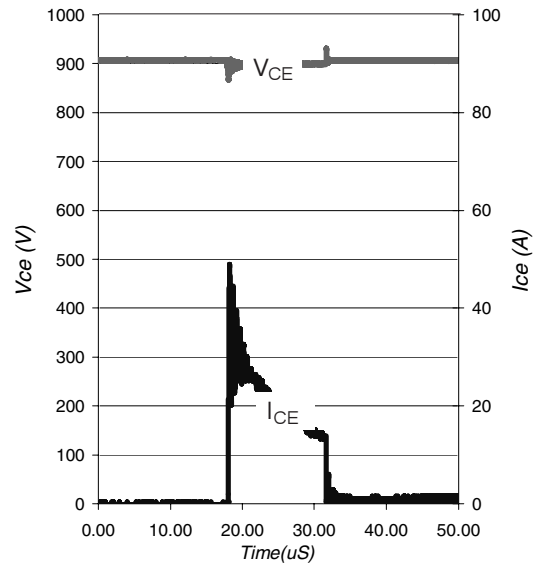


Fig.WF4-Typ. S.C. Waveform  
@  $T_C = 150^\circ\text{C}$  using Fig. CT3

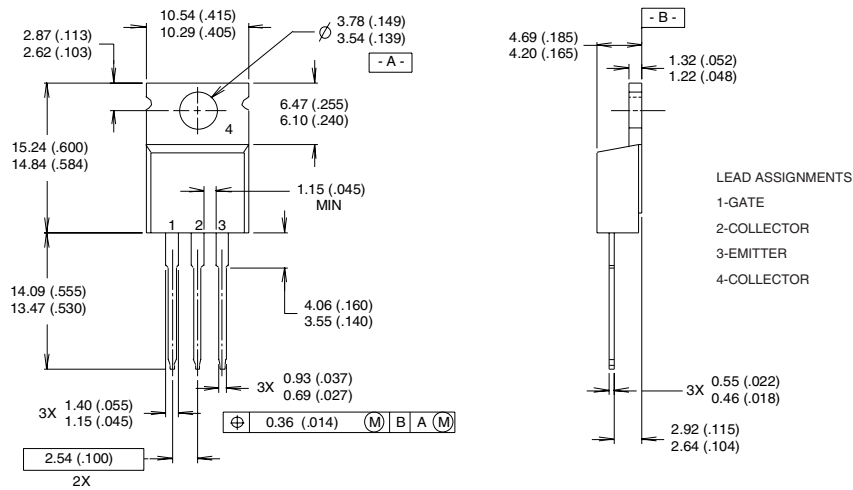
# IRGB5B120KD



## Package Outline

### TO-220AB

Dimensions are shown in millimeters (inches)

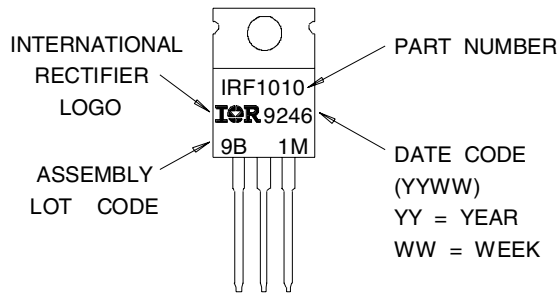


- NOTES:  
 1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.  
 2 CONTROLLING DIMENSION : INCH  
 3 OUTLINE CONFORMS TO JEDEC OUTLINE TO-220AB.  
 4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURRS.

## Part Marking Information

### TO-220AB

EXAMPLE : THIS IS AN IRF1010  
 WITH ASSEMBLY  
 LOT CODE 9B1M



TO-220AB package is not recommended for Surface Mount Application

Data and specifications subject to change without notice.  
 This product has been designed and qualified for Industrial market.  
 Qualification Standards can be found on IR's Web site.



IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105  
 TAC Fax: (310) 252-7903

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